

<b>Notice of References Cited</b>	Application/Control No. 10/529,547	Applicant(s)/Patent Under Reexamination HONKURA ET AL.	
	Examiner John P. Sheehan	Art Unit 1742	Page 1 of 1

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*	C	US-2003/0047240 A1	03-2003	Honkura et al.	148/105
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**NON-PATENT DOCUMENTS**

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